

Notice of References Cited	Application/Control No. 10/824,434		Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner ALVIN H. TAN		Art Unit 2173	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,509,580	03-2009	Sezan et al.	715/719
*	B	US-6,941,356	09-2005	Meyerson, Matthew Scott	709/220
*	C	US-6,161,134	12-2000	Wang et al.	709/220
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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